

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/797,260	WENG ET AL.	
Examiner	Art Unit	
Caridad M. Everhart	2891	

	SEARCHED			
Class	Subclass	Date	Examiner	
438	29	4/6/2005	СМЕ	
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TAI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST(attached)	4/6/2005	CME		
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